### INTEGRATED CIRCUITS

# DATA SHEET



### 74ABT657

Octal transceiver with parity generator/checker (3-State)

Product specification

1995 Dec 11

IC23 Data Handbook





## Octal transceiver with parity generator/checker (3-State)

74ABT657

#### **FEATURES**

- Combinational functions in one package
- Low static and dynamic power dissipation with high speed and high output drive
- Output capability: +64mA/–32mA
- Power-up 3-State
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

#### **DESCRIPTION**

The 74ABT657 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT657 is an octal transceiver featuring non-inverting buffers with 3-State outputs and an 8-bit parity generator/checker, and is intended for bus-oriented applications. The buffers have a guaranteed current sinking capability of 64mA. The Transmit/Receive (T/R) input determines the direction of the data flow through the bidirectional transceivers. Transmit (active-High) enables data from A ports to B ports; Receive (active-Low) enables data from B ports to A ports.

The Output Enable (OE) input disables both the A and B ports by placing them in a high impedance condition when the OE input is High. The parity select (ODD/EVEN) input gives the user the option of odd or even parity systems. The parity (PARITY) pin is an output from the generator/checker when transmitting from the port A to B  $(T/\overline{R} = High)$  and an input when receiving from port B to A port  $(T/\overline{R}$ = Low). When transmitting  $(T/\overline{R} = High)$  the parity select (ODD/EVEN) input is set, then the A port data is polled to determine the number of High bits. The parity (PARITY) output then goes to the logic state determined by the parity select (ODD/EVEN) setting and by the number of High bits on port A. For example, if the parity select (ODD/EVEN) is set Low (even parity), and the number of High bits on port A is odd, then the parity (PARITY) output will be High, transmitting even parity. If the number of High bits on port A is even, then the parity (PARITY) output will be Low, keeping even parity. When in receive mode  $(T/\overline{R} = Low)$  the B port is polled to determine the number of High bits. If parity select (ODD/EVEN) is Low (even parity) and the number of Highs on port B is:

- (1) odd and the parity (PARITY) input is High, then  $\overline{\mbox{ERROR}}$  will be High, signifying no error.
- (2) even and the parity (PARITY) input is High, then ERROR will be asserted Low, indicating an error.

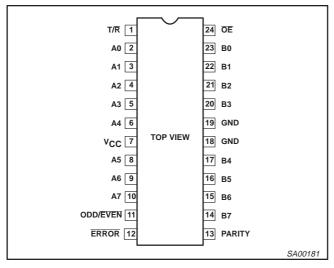
#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER		CONDITIONS T <sub>amb</sub> = 25°C; GND = 0V	TYPICAL	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay An to Bn or Bn to An	С	$L = 50$ pF; $V_{CC} = 5V$	3.3	ns
C <sub>IN</sub>	Input capacitance	V	$_{\parallel}$ = 0V or V <sub>CC</sub>	4	pF
C <sub>I/O</sub>	I/O capacitance		utputs disabled; O = 0V or V <sub>CC</sub>	7	pF
I <sub>CCZ</sub>	Total supply current	0	utputs disabled; V <sub>CC</sub> =5.5V	500	nA

#### **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
24-Pin Plastic DIP	-40°C to +85°C	74ABT657 N	74ABT657 N	SOT222-1
24-Pin plastic SO	-40°C to +85°C	74ABT657 D	74ABT657 D	SOT137-1
24-Pin Plastic SSOP Type II	-40°C to +85°C	74ABT657 DB	74ABT657 DB	SOT340-1
24-Pin Plastic TSSOP Type I	-40°C to +85°C	74ABT657 PW	74ABT657PW DH	SOT355-1

#### **PIN CONFIGURATION**



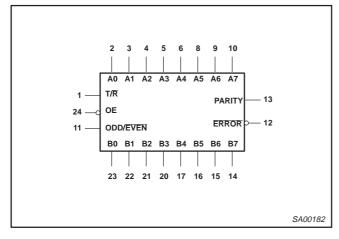
#### **PIN DESCRIPTION**

SYMBOL	PIN NUMBER	NAME AND FUNCTION
13	PARITY	Parity output
11	ODD/EVEN	Parity select input
12	ERROR	Error output
1	T/R	Transmit/receive input
2, 3, 4, 5, 6, 8, 9, 10	A0 - A7	A port 3-State outputs
23, 22, 21, 20, 17, 16, 15, 14	B0 - B7	B port 3-State outputs
24	ŌĒ	Output enable input (active-Low)
18, 19	GND	Ground (0V)
7	V <sub>CC</sub>	Positive supply voltage

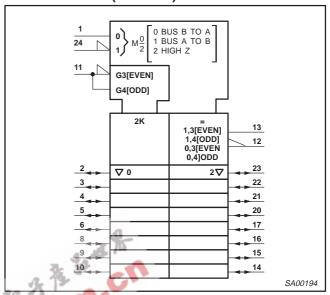
### Octal transceiver with parity generator/checker (3-State)

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#### **LOGIC SYMBOL**



### LOGIC SYMBOL (IEEE/IEC)



### **FUNCTION TABLE**

		The second secon				
NUMBER OF HIGH INPUTS	1	INPUTS		INPUT/ OUTPUT	OUTPUTS	
	OE	T/R	ODD/EVEN	PARITY	ERROR	OUTPUTS MODE
0, 2, 4, 6, 8	L L L	HHLLLL	H	H	Z Z H L L	Transmit Transmit Receive Receive Receive Receive
1, 3, 5, 7	L L L	H H L L L L	I	LILIL	Z Z L H L	Transmit Transmit Receive Receive Receive Receive
Don't care	Н	Х	Х	Z	Z	3-State

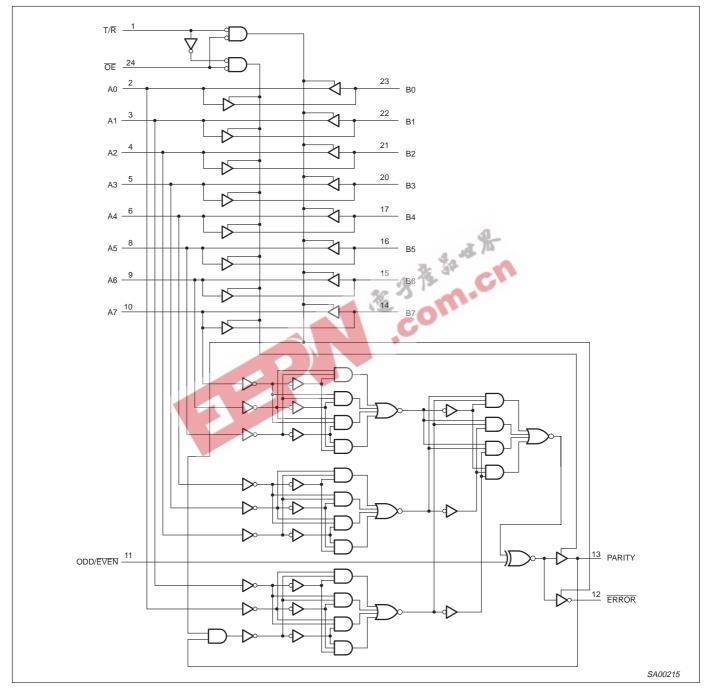
H = High voltage level L = Low voltage level

L = Low voltage level
X = Don't care
Z = High impedance "off" state

## Octal transceiver with parity generator/checker (3-State)

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### **LOGIC DIAGRAM**



### Octal transceiver with parity generator/checker (3-State)

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#### **ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>**

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +7.0	V
I <sub>IK</sub>	DC input diode current	V <sub>I</sub> < 0	-18	mA
VI	DC input voltage <sup>3</sup>		-1.2 to +7.0	V
I <sub>OK</sub>	DC output diode current	V <sub>O</sub> < 0	-50	mA
V <sub>OUT</sub>	DC output voltage <sup>3</sup>	output in Off or High state	-0.5 to +5.5	V
lout	DC output current	output in Low state	128	mA
T <sub>stg</sub>	Storage temperature range		-65 to 150	°C

#### NOTES:

- 1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to
- absolute-maximum-rated conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
  The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
  The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIM	UNIT	
OTHIBOL	TANAMETER	Min	Max	J
V <sub>CC</sub>	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V <sub>CC</sub>	V
V <sub>IH</sub>	High-level input voltage	2.0		V
V <sub>IL</sub>	Low-level input voltage		0.8	V
I <sub>OH</sub>	High-level output current		-32	mA
I <sub>OL</sub>	Low-level output current		64	mA
Δt/Δν	Input transition rise or fall rate	0	5	ns/V
T <sub>amb</sub>	Operating free-air temperature range	-40	+85	°C

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#### DC ELECTRICAL CHARACTERISTICS

	PARAMETER					LIMITS			
SYMBOL			TEST CONDITIONS		T <sub>amb</sub> = +25°C			T <sub>amb</sub> = -40°C to +85°C	
				Min	Тур	Max	Min	Max	1
V <sub>IK</sub>	Input clamp volt	age	$V_{CC} = 4.5V; I_{IK} = -18mA$		-0.9	-1.2		-1.2	V
			$V_{CC} = 4.5V$ ; $I_{OH} = -3mA$ ; $V_I = V_{IL}$ or $V_{IH}$	2.5	3.5		2.5		V
V <sub>OH</sub>	High-level outpu	ut voltage	$V_{CC} = 5.0V$ ; $I_{OH} = -3mA$ ; $V_I = V_{IL}$ or $V_{IH}$	3.0	4.0		3.0		V
			$V_{CC} = 4.5V$ ; $I_{OH} = -32mA$ ; $V_I = V_{IL}$ or $V_{IH}$	2.0	2.6		2.0		V
V <sub>OL</sub>	Low-level outpu	t voltage	$V_{CC} = 4.5V$ ; $I_{OL} = 64mA$ ; $V_I = V_{IL}$ or $V_{IH}$		0.42	0.55		0.55	V
II	Input leakage	Control pins	$V_{CC} = 5.5V; V_I = GND \text{ or } 5.5V$		±0.01	±1.0		±1.0	μΑ
	current	Data pins	$V_{CC} = 5.5V; V_I = GND \text{ or } 5.5V$		±5	±100		±100	μΑ
I <sub>OFF</sub>	Power-off leaka	ge current	$V_{CC}$ 0.0V; $V_O$ or $V_I \le 4.5V$		±5.0	±100		±100	μΑ
I <sub>PU</sub> I <sub>PD</sub>	Power-up/down 3-State output current <sup>3</sup>		$V_{\underline{CC}}$ 2.0V; $V_{\underline{O}}$ = 0.5V; $V_{\underline{I}}$ = GND or $V_{\underline{CC}}$ ; $V_{\underline{OE}}$ = $V_{\underline{CC}}$		±5.0	±50		±50	μА
I <sub>IH</sub> + I <sub>OZH</sub>	3-State output I	ligh current	$V_{CC} = 5.5V; V_{O} = 2.7V; V_{I} = V_{IL} \text{ or } V_{IH}$	3 15	5.0	50		50	μΑ
I <sub>IL</sub> + I <sub>OZL</sub>	3-State output L	ow current	$V_{CC} = 5.5V; V_O = 0.5V; V_I = V_{IL} \text{ or } V_{IH}$		<b>-</b> 5.0	-50		-50	μΑ
I <sub>CEX</sub>	Output High lea	kage current	$V_{CC} = 5.5V; V_{O} = 5.5V; V_{I} = GND \text{ or } V_{CC}$	C	5.0	50		50	μΑ
I <sub>O</sub>	Output current <sup>1</sup>		V <sub>CC</sub> = 5.5V; V <sub>O</sub> = 2.5V	<b>-5</b> 0	-80	-180	-50	-180	mA
I <sub>CCH</sub>			$V_{CC}$ = 5.5V; Outputs High, $V_I$ = GND or $V_{CC}$		0.5	250		250	μΑ
I <sub>CCL</sub>	Quiescent supp	ly current	$V_{CC}$ = 5.5V; Outputs Low, $V_{I}$ = GND or $V_{CC}$		20	30		30	mA
I <sub>CCZ</sub>	]		$V_{CC} = 5.5V$ ; Outputs 3-State; $V_{I} = GND \text{ or } V_{CC}$		0.5	250		250	μА
			Outputs enabled, one data input at 3.4V, other inputs at $V_{CC}$ or GND; $V_{CC} = 5.5V$		0.5	1.5		1.5	mA
Δl <sub>CC</sub>	Additional supp input pin <sup>2</sup>	ly current per	Outputs 3-State, one data input at 3.4V, other inputs at $V_{CC}$ or GND; $V_{CC}$ = 5.5V		50	250		250	μА
			Outputs 3-State, one enable input at 3.4V, other inputs at $V_{CC}$ or GND; $V_{CC} = 5.5V$		0.5	1.5		1.5	mA

NOTES:

1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

2. This is the increase in supply current for each input at 3.4V.

3. This parameter is valid for any V<sub>CC</sub> between 0V and 2.1V with a transition time of up to 10msec. For V<sub>CC</sub> = 2.1V to V<sub>CC</sub> = 5V ± 10%, a transition time of up to 100μsec is permitted.

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#### **AC CHARACTERISTICS**

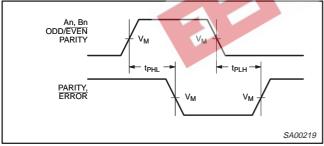
GND = 0V;  $t_R$  =  $t_F$  = 2.5ns;  $C_L$  = 50pF,  $R_L$  = 500 $\Omega$ 

			LIMITS					
SYMBOL	PARAMETER	WAVEFORMS	T <sub>amb</sub> = +25°C V <sub>CC</sub> = +5.0V			$T_{amb} = -44$ $V_{CC} = +5$	UNIT	
			Min	Тур	Max	Min	Max	]
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay An to Bn or Bn to An	2	1.1 1.2	3.3 3.0	5.0 4.3	1.1 1.2	5.5 4.8	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay An to PARITY	1, 2	2.5 2.8	6.5 7.0	8.7 9.1	2.5 2.8	10.1 10.6	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay ODD/EVEN to PARITY, ERROR	1, 2	1.7 1.9	5.0 5.0	6.6 6.6	1.7 1.9	7.3 7.3	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay Bn to ERROR	1, 2	3.9 4.0	9.2 9.6	11.7 12.1	3.9 4.0	13.8 14.5	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay PARITY to ERROR	1, 2	2.7 3.2	6.0 6.4	7.6 8.0	2.7 3.2	9.4 9.4	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output enable time <sup>1</sup> to High or Low level	3, 4	1.3 1.9	3.8 4.4	5.6 7.0	1.3 1.9	6.6 8.2	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output disable time from High or Low level	3, 4	2.4 2.7	5.1 5.4	7.0 7.6	2.4 2.7	7.6 8.1	ns

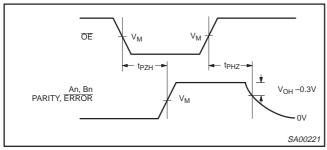
#### NOTES:

#### **AC WAVEFORMS**

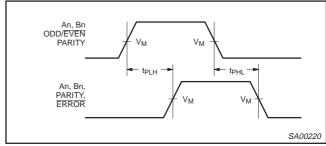
NOTE: For all waveforms,  $V_M = 1.5V_1$ 



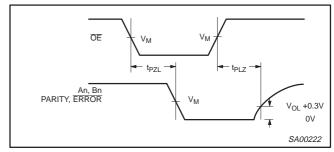
**Waveform 1. Propagation Delay For Inverting Output** 



Waveform 3. 3-State Output Enable Time to High Level and Output Disable Time from High Level



Waveform 2. Propagation Delay For Non-Inverting Output



Waveform 4. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

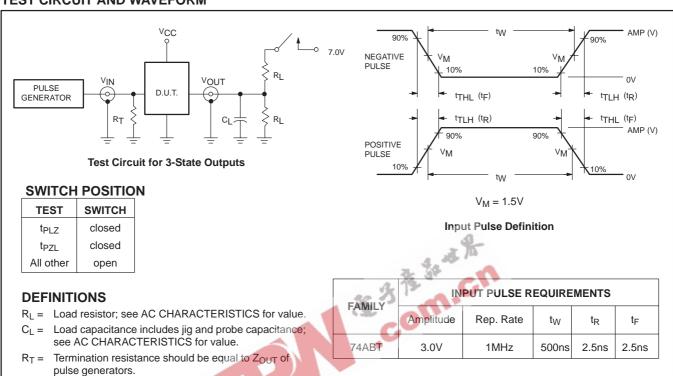
These delay times reflect the 3-State recovery time only and do not include the delay through the buffers and the parity check circuitry which affect the ERROR output. To assure *valid* information at the ERROR pin, time must be allowed for the signal to propagate through the drivers (B to A), through the parity check circuitry (same as A to PARITY), and to the ERROR output. *Valid* data at the ERROR pin ≥ (B to A) + (A to PARITY).

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SA00012

#### **TEST CIRCUIT AND WAVEFORM**



Octal transceiver with parity generator/checker (3-State)	74ABT657
DIP24: plastic dual in-line package; 24 leads (300 mil)	SOT222-1
SO24: plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1
SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1
TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1



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#### **NOTES**



## Octal transceiver with parity generator/checker (3-State)

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